

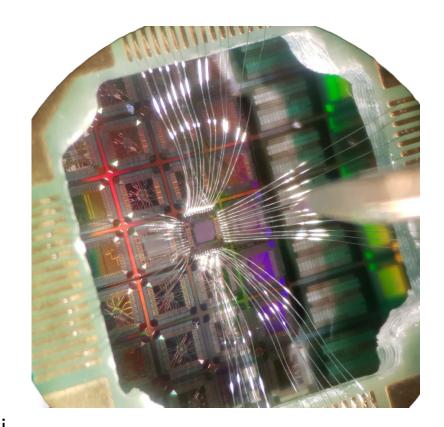






Università degli Studi di Bari Aldo Moro Dipartimento Interateneo di Fisica "*Michelangelo Merlin*"

# APTS OA Laboratory Activities and TB Analysis



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Bari, 5 novembre 2024









1:10

**Baseline Calibration** | Test Pulsing

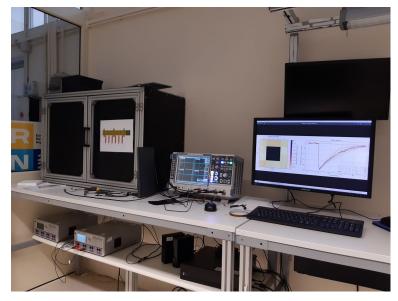
Operating point

**Pulse Scanning** 

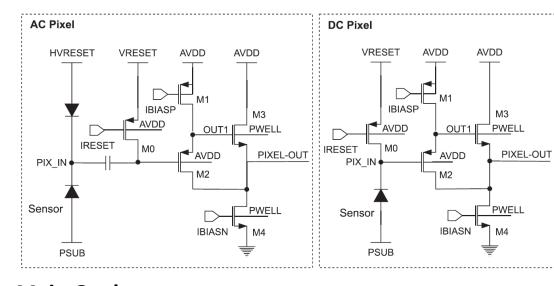
X-rays source meas.

Peripheral OPAMP

PIX-OUT



Oue High Technology Lab



#### **Main Goals:**

Electronic and bias parameters fine tuning to achieve the best performance (no simulations available)

Direct investigation of the pixel chip with radiation ≈ MIP particle





## **Baseline Noise evaluation**





**Baseline Calibration** 

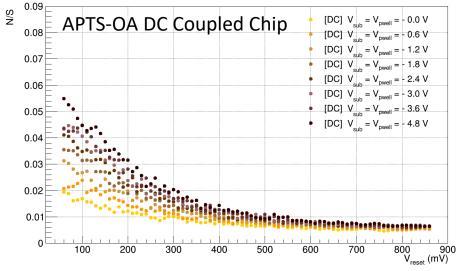
**Test Pulsing** 

Operating point

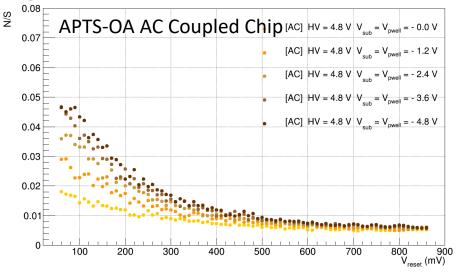
**Pulse Scanning** 

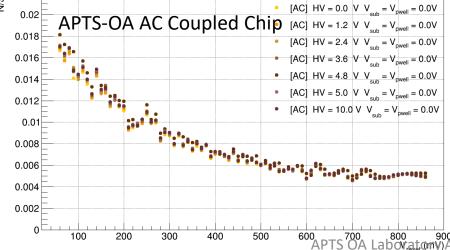
X-rays source meas.

#### Goal: Investigate the bias voltage effect on the output voltage









- Meaningful N/S variation w.r.t. V<sub>sub</sub> and V<sub>pwell</sub> (DC and AC coupled).
- Negligible N/S variation w.r.t. HV (only AC coupled).





# AC – DC chip prototype comparison (INFN)





**Baseline Calibration** 

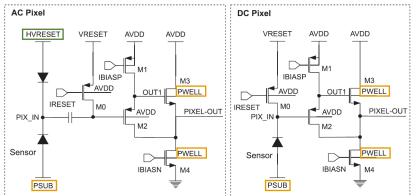
**Test Pulsing** 

Operating point

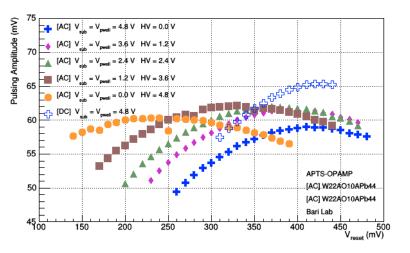
**Pulse Scanning** 

X-rays source meas.

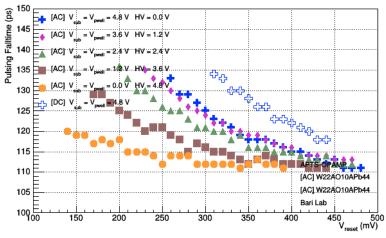
#### Goal: investigate bias voltages additive effect (AC) and compare (DC)

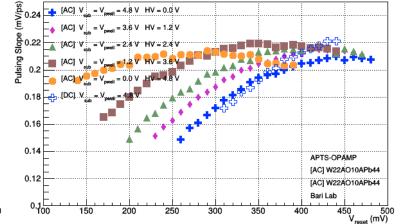


	HV (V)	V <sub>sub/pwell</sub> (-V)
AC	0	4.8
	1.2	3.6
	2.4	2.4
	1.2	3.6
	4.8	0
DC		4.8



No additive effect from signal amplitude comparison.





Fall time and slope convergence at high  $V_{reset}$ .









**Baseline Calibration** 

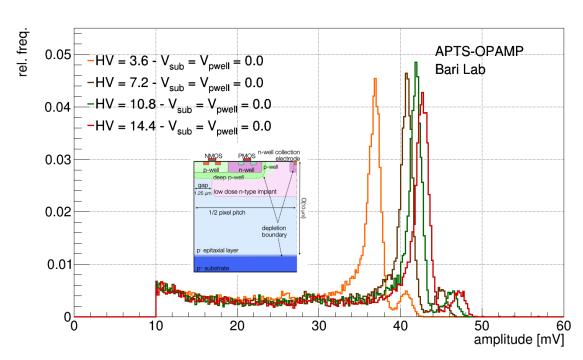
**Test Pulsing** 

Operating point

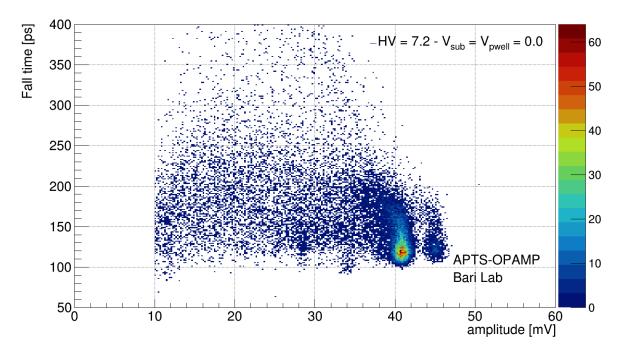
**Pulse Scanning** 

X-rays source meas.

#### Goal: direct investigation of pixels chip



 $K_{\alpha}$  and  $K_{\beta}$  peaks well reconstructed.



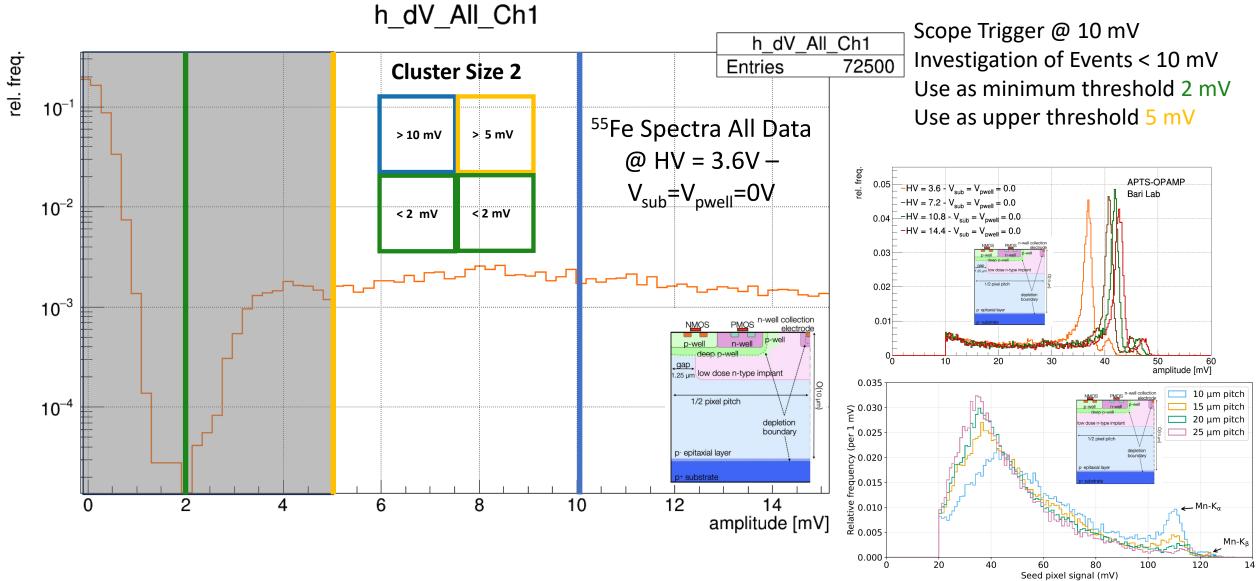
Fall time estimated at 110 ps.









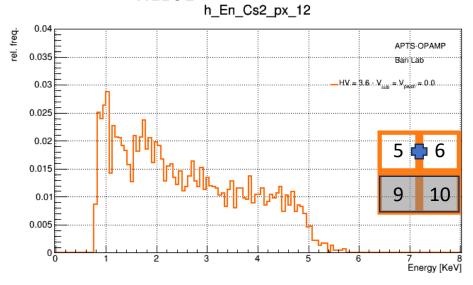


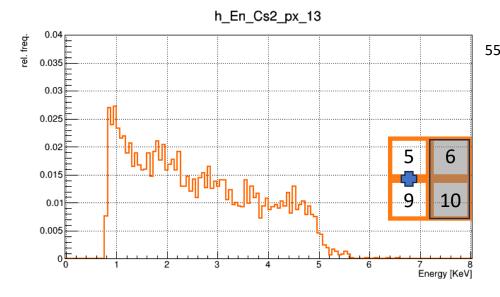


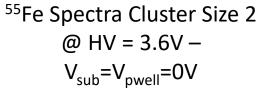






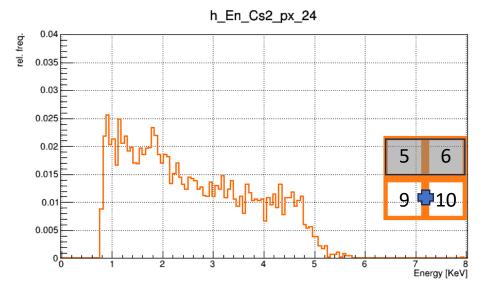


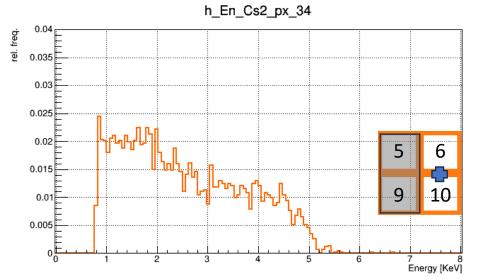




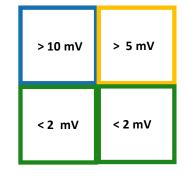


Summing signals from adjacent pixels in the same event







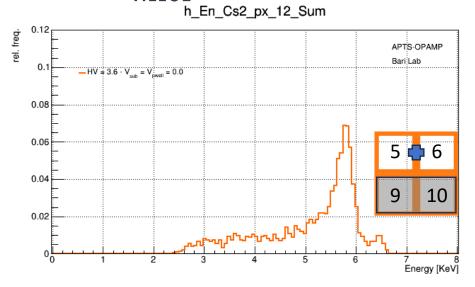


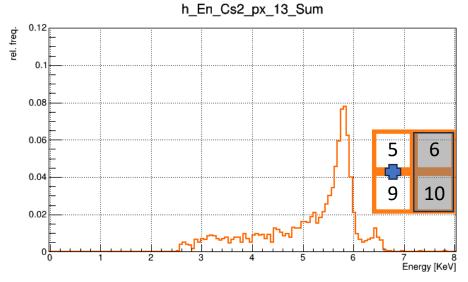


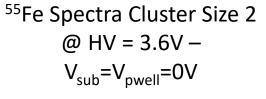


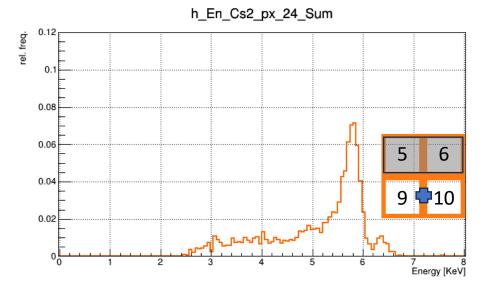


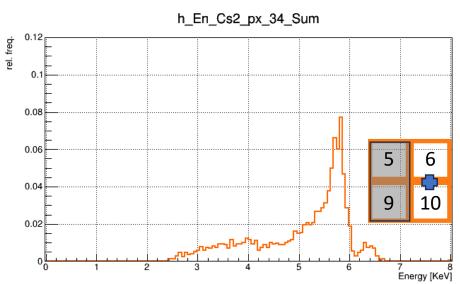












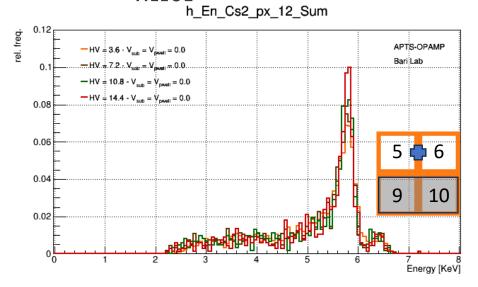
Summing signals from adjacent pixels in the same event: it allows to reconstruct the two <sup>55</sup>Fe peaks

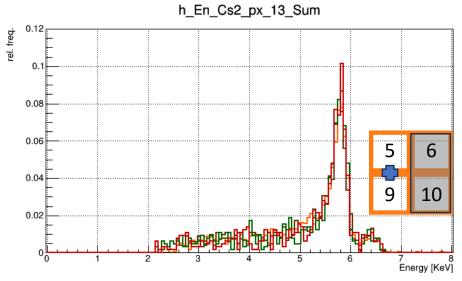


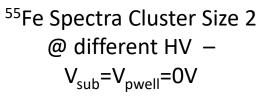


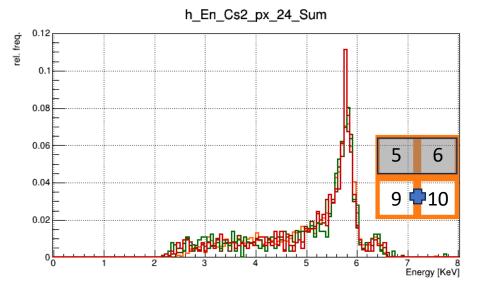


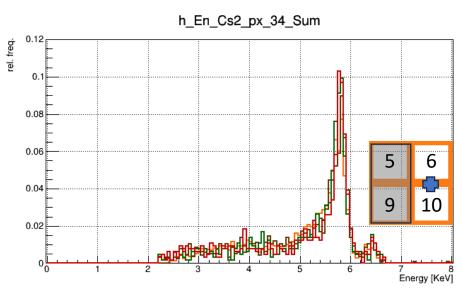












Summing signals from adjacent pixels in the same event: it allows to reconstruct the two <sup>55</sup>Fe peaks

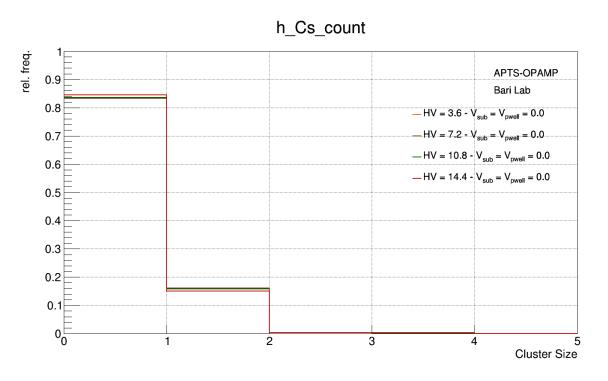


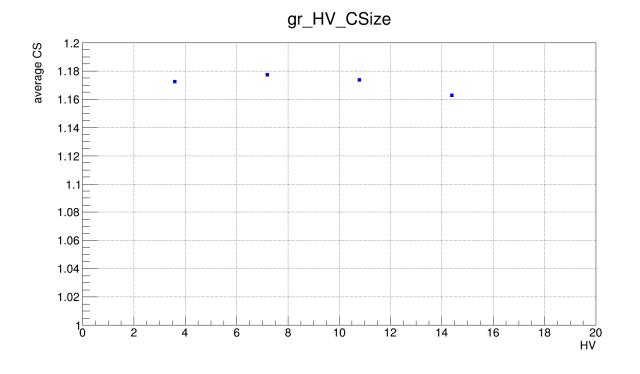






#### Average Cluster Size at different HV





CS1: more than 80%

**CS2**: less than 20%

CS average: ≈ 1.17





# **APTS OA TB Analysis**

align

Correlations

Tracking4D

ClusteringSpatial

prealign

Correlations

ClusteringSpatial







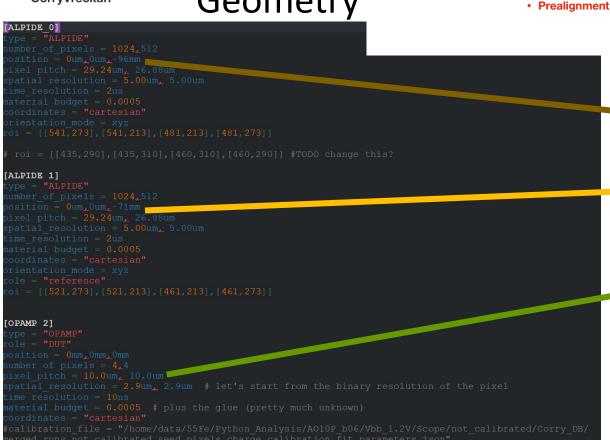
Corryvreckan

**Processes** 

createmask

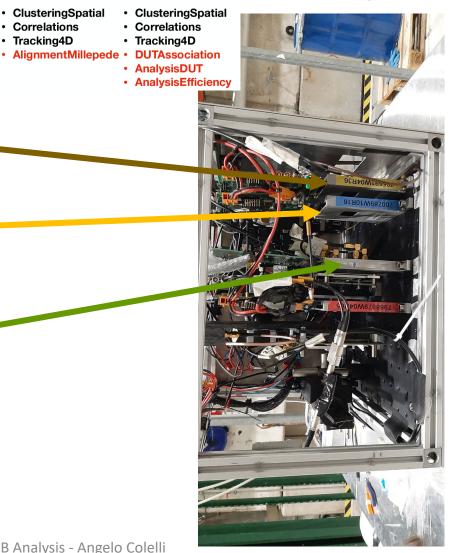
MaskCreator

Geometry



#### Telescope

analyse







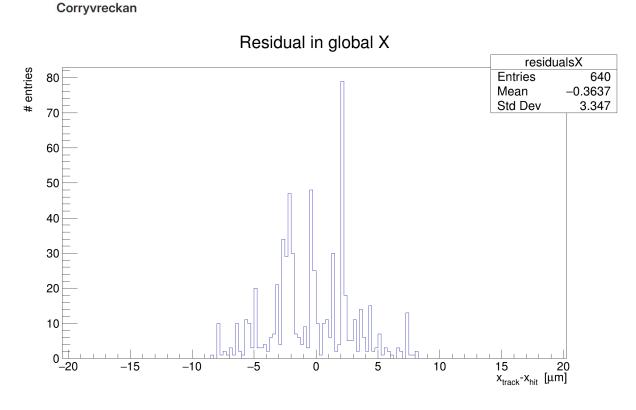
# **APTS OA TB Analysis**

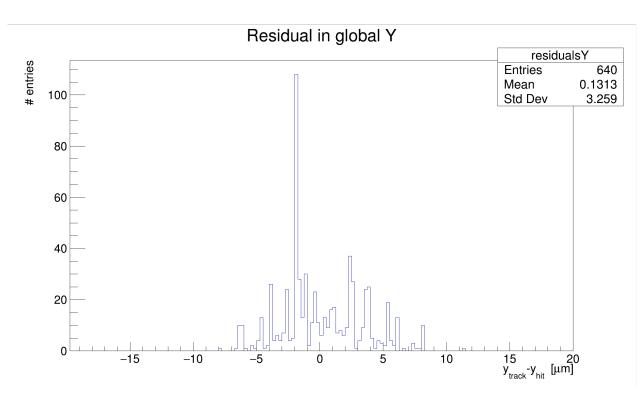






### QA running to validate data





Next Step: Tracking and Timing analysis

# Backup Slides

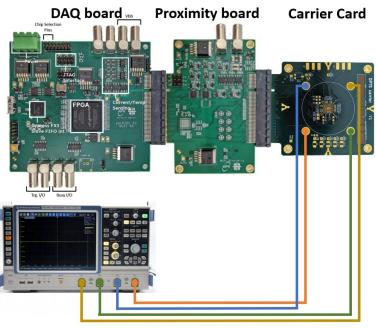




# **APTS OA Chip Readout System**





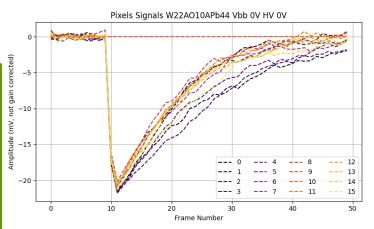


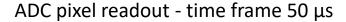
Code development (Python and C++) for:

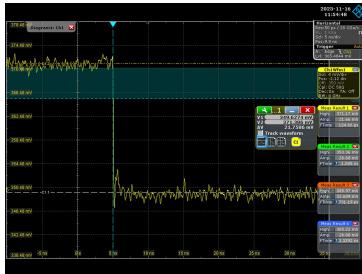
- fully automatized data acquisition, trigger and communication between the experimental setup and the oscilloscope
- Data dumping and analysis

Approved and part of the collaboration repository (GitLab)

- An FPGA-based DAQ board via USB interface (5V power) PC controlled.
- A Proximity board:
  - host the analog to digital converters (ADCs) for the readout of peripheral pixels
  - · bias the chip.
- A Carrier Card to which the chip is glued and bonded
  - 4 innermost pixels directly readout with an oscilloscope Rohde & Schwarz,
     RTO 1044 (20GSa/s 4 GHz) by high bandwidth SMA connectors
  - 12 outer pixels readout by 4 MHz ADCs







Scope pixel readout - time frame 50 ns









**Baseline Calibration** 

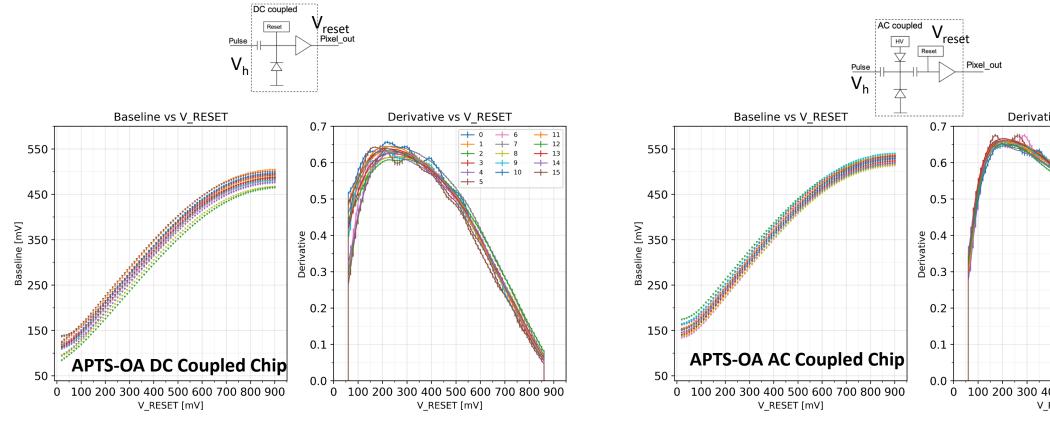
**Test Pulsing** 

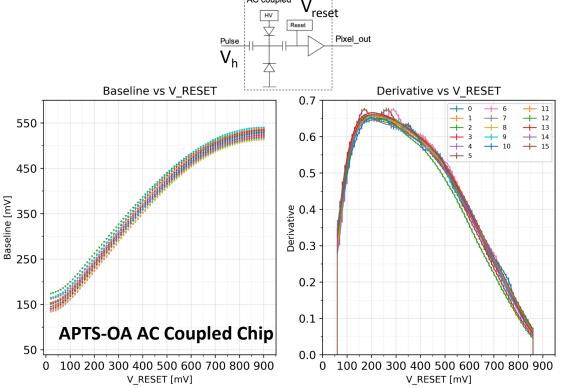
Operating point

**Pulse Scanning** 

X-rays source meas.

**Goal**: Study output voltage w.r.t. voltage reset  $V_{reset}$ 





**Analysis**: calculation of  $\Delta$ baseline/ $\Delta V_{reset}$  to find best circuitry response in a wide  $V_{reset}$  range









**Baseline Calibration** 

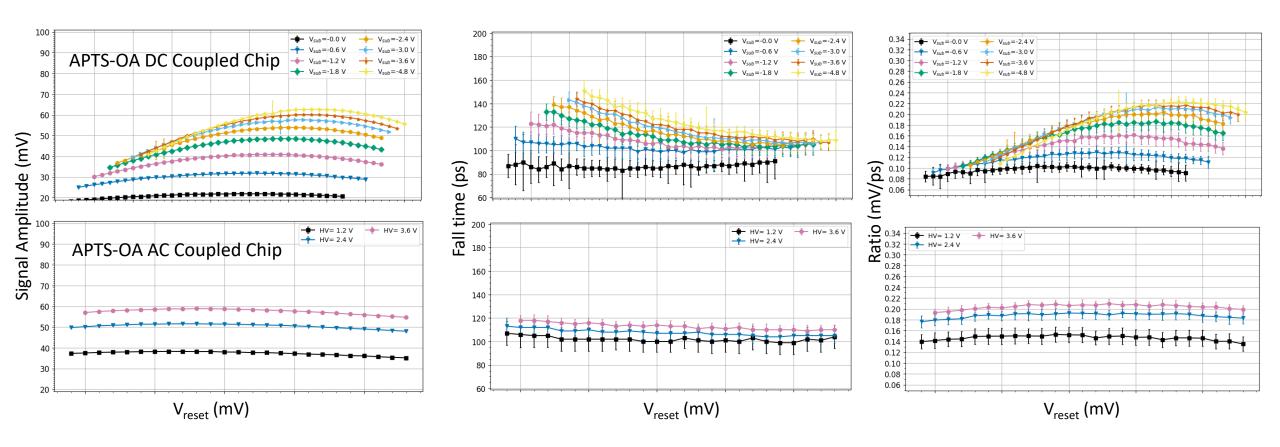
**Test Pulsing** 

Operating point

**Pulse Scanning** 

X-rays source meas.

#### **Goal**: find best circuitry response.



Analysis:  $\Delta$ amplitude/ $\Delta$ V<sub>reset</sub> to find best V<sub>reset</sub> @ maximum signal amplitude and minimum signal Fall Time









**Baseline Calibration** 

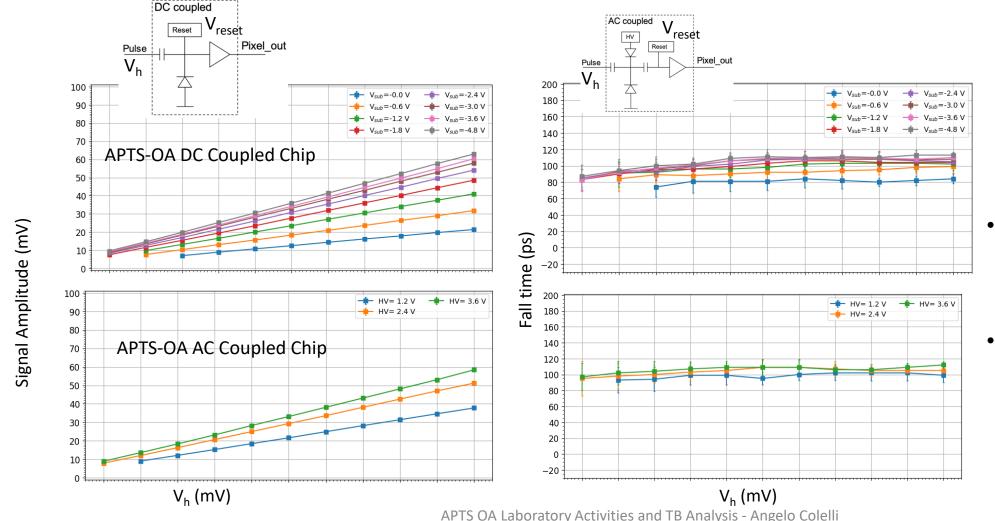
**Test Pulsing** 

Operating point

**Pulse Scanning** 

X-rays source meas.

**Goal**: evaluation of the sensor circuitry response at the V<sub>reset</sub> operationg point



- Signal amplitude linear response w.r.t. injection voltage V<sub>h</sub>
- Almost stable fall time.

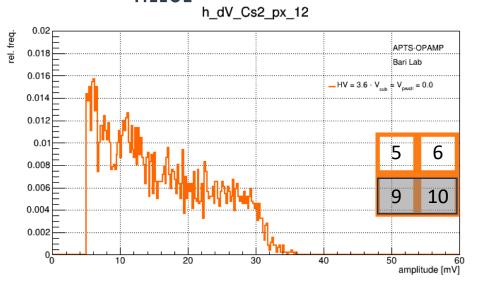


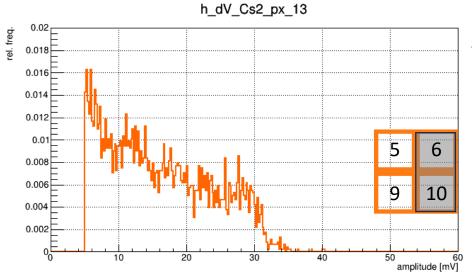


# **APTS OA Cluster Size Investigation** (INFINITION OF INFINITION OF INFINI









<sup>55</sup>Fe Spectra Cluster Size 2 @ HV = 3.6V - $V_{sub} = V_{pwell} = 0V$ 

